

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10811977	TAKAYAMA ET AL.
	Examiner	Art Unit
	Chang, Rick K	3726

SEARCHED

Class	Subclass	Date	Examiner
29	863,854,861,865,866,867,33 F,33 M,745,747,748,749,750,751,753,761	12/22/06	RC
72	416,16.2,16.8,17.3		
73	81-87		

SEARCH NOTES

Search Notes	Date	Examiner
EAST SEARCH	12/22/06	RC

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner